Search Notes



Applicant(s)/Patent under Reexamination

10/643,669 Examiner

John Kim

TANNER ET AL.

1723

SEARCHED				
Class	Subclass	Date	Examiner	
210	501, 502.1, 504, 505, 506, 508	6/27/2007	JK	
	266, 282			
	497.1			
	473, 477			
	252, 259			
	257.1			
	257.2			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	_				
	,				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	3/1/2006	YK.		
See EAST Search History 210/501,502.1,504,505,506,508,266,2 82,497.1,473,477,252,257.1,257.2,25 9	3/3/2006	YK		
EAST Search History	8/23/2006	JK		
EAST Search History	6/27/2007	JK		
	·			
	·			
· ·				